MV0530VX

300W, HF-0.5GHz 50V High Power RF LDMOS

Description

The MV0530VX is a 300W single ended 50V LDMOS, unmatched for any applications within HF-0.5GHz

It supports CW, and pulsed and any modulated signal at either saturated or linear application.

It can be the drop-in replacement of its equivalent 300W single ended VDMOS like SD2933/VRF2933 with improved RF performance like higher efficiency

Typical performance(on Innogration test board with device soldered)
Signal: CW , Vgs=3.35v,Vds=50v,Idq=200mA

Frog(MHz)	Pin(dBm)	Pout(dBm)	Pout(W)	lds(A)	Gain(dB)	Eff(%)	2 nd	3 rd
Freq(MHz)	FIII(GDIII)	Foul(dBIII)	Foul(VV)	ius(A)	Gairi(ub)		Harmonic(dB)	Harmonic(dB)
30	33.2	55.6	350	9.5	24	74	-27	-39

Features

- · High Efficiency and Linear Gain Operations
- Integrated ESD Protection
- · Excellent thermal stability, low HCI drift
- Large Positive and Negative Gate/Source Voltage Range for Improved Class C Operation
- Pb-free, RoHS-compliant

Suitable Applications

- 30-88MHz (Ground communication)
- 54-88MHz (TV VHF I)
- 88-108MHz (FM)
- 160-230MHz (TV VHF III)
- 136-174MHz (Commercial ground communication)
- Laser Exciter
- Synchrotron
- MRI
- Plasma generator
- Weather Radar

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
DrainSource Voltage	V _{DSS}	+135	Vdc
GateSource Voltage	V _{GS}	-10 to +10	Vdc
Operating Voltage	V_{DD}	+55	Vdc
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	Tc	+150	°C
Operating Junction Temperature	T₃	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit	
Thermal Resistance, Junction to Case	Do 10	0.5	00/14/	
T _C = 85°C, T _J =200°C, DC test	R⊕JC	0.5	°C/W	

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22A114)	Class 2

Table 4. Electrical Characteristics (T_A = 25 °C unless otherwise noted)

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Characteristic	Symbol	Min	Тур	Max	Unit	
DC Characteristics	C Characteristics					
Drain-Source Voltage			135		V	
V _{GS} =0, I _{DS} =1.0mA	$V_{(BR)DSS}$		135		V	
Zero Gate Voltage Drain Leakage Current				1	^	
$(V_{DS} = 75V, V_{GS} = 0 V)$	I _{DSS}			ı	μΑ	
Zero Gate Voltage Drain Leakage Current				1	^	
$(V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V})$	I _{DSS}			I	μΑ	
GateSource Leakage Current				1		
$(V_{GS} = 10 \text{ V}, V_{DS} = 0 \text{ V})$	I _{GSS}			I	μΑ	
Gate Threshold Voltage	\/ (+b)		2.65		V	
$(V_{DS} = 50V, I_D = 600 \mu A)$	V _{GS} (th)		2.03		V	
Gate Quiescent Voltage	$V_{GS(Q)}$		3.4		V	
$(V_{DD} = 50 \text{ V}, I_D = 200 \text{ mA}, \text{Measured in Functional Test})$	V GS(Q)		3.4		V	
Drain source on state resistance	Rds(on)		180		mΩ	
(Vds=0.1V, Vgs=10V)	rtus(OII)		100		11152	
Common Source Input Capacitance	C _{ISS}		220		nE	
(V _{GS} = 0V, V _{DS} =50 V, f = 1 MHz)	Ciss		220		pF	
Common Source Output Capacitance	Coss		65		pF	
(V _{GS} = 0V, V _{DS} =50 V, f = 1 MHz)	Coss				μι-	
Common Source Feedback Capacitance	C _{RSS}		1.5		pF	
(V _{GS} = 0V, V _{DS} =50 V, f = 1 MHz)	ORSS		1.5		ρi	

 $\textbf{Load Mismatch (In Innogration Test Fixture, 50 ohm system):} \ V_{DD} = 50 \ Vdc, \ I_{DQ} = 200 \ mA, \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \ cycle: 10\% \ and \ f = 108 MHz, \ pulse \ width: 100 us, \ duty \$

Load 20:1 All phase angles, at 350W Pulsed CW Output Power	No Device Degradation
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TYPICAL CHARACTERISTICS

Figure 1: CW Gain and Power Efficiency as a Function of Pout at 30MHz

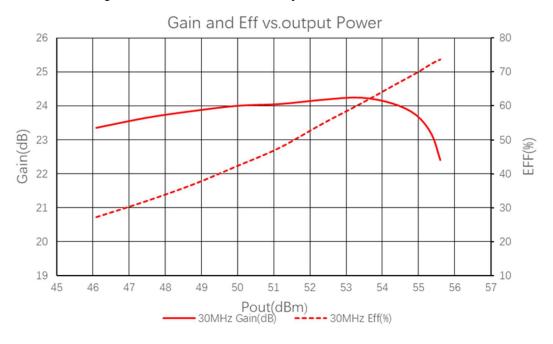


Figure 1: Network analyzer output S11/221



Reference Circuit of Test Fixture Assembly Diagram (PCB file upon request)

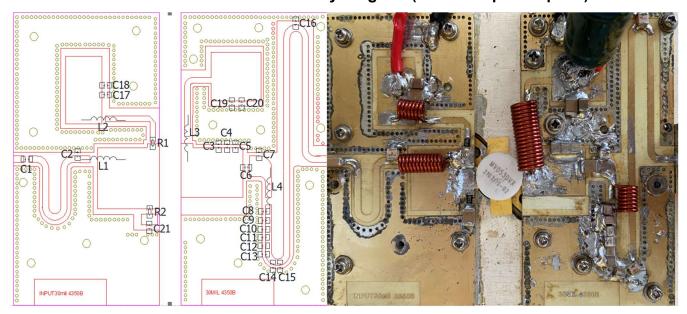
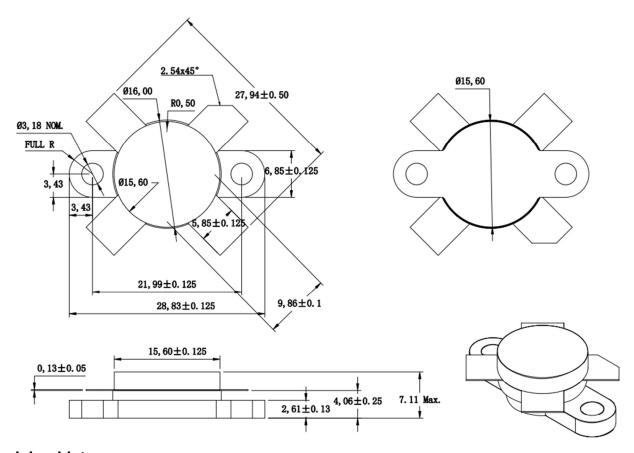


Table 1. Test Circuit Component Designations and Values (30MHz)

Component	Description	Suggestion
C1,C6,C17,C19,C21	10nF	CC1812KKX7RDBB103
C2	200pF	ATC800B
C3,C4,C14	68pF	ATC800B
C5,C12	100pF	ATC800B
C7,C10,C11,C13	47pF	DLC70B
C8	24pF	DLC70B
C9,C16	22pF	DLC70B
C15	12pF	DLC70B
C18,C20	10uF	10uF/50V
R1,R2	Chip Resistor,10ohm	1206
L1	12 turns, Inside diameter 3mm	
L2	7 turns, Inside diameter 3mm	
T2,T3	18 turns, Inside diameter 5mm	
T4,T5	7 turns, Inside diameter 3mm	

Package Outline

Flanged ceramic package; 2 mounting holes; 2 leads (1—Gate, 2—Drain, 3—Source)



Revision history

Table 5. Document revision history

Date	Revision	Datasheet Status
2021/6/22	Rev 1.0	Preliminary datasheet
2022/5/24	Rev 1.1	Modification of V4E package picture and drawing
2023/11/21	Rev 2.0	Modify drawing of extended leads length
2023/12/4	Rev 3.0	Finalized by changing to V4E1 package

Application data based on ZL-21-15

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